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IAP9 Rec'd PCT/PTO 12 DEC 2005

Sheet 1 of 2
IDS LIST OF REFERENCES
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(FORM PTO-1449)
DATED: December 12, 2005

Atty. Docket No.: 4929 Serial No.:
to be assigned

Applicant: Haruyo FUKUI et al.

U.S. Filing Date: December 12, 2005 Art Unit:

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EXAMINER'S SIGNATURE	DATE CONSIDERED
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